

<b>Notice of References Cited</b>	Application/Control No. 10/670,587	Applicant(s)/Patent Under Reexamination BIAN, JINRU	
	Examiner Gregory E. Webb	Art Unit 1751	Page 1 of 1

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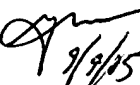
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**NON-PATENT DOCUMENTS**

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9/9/05